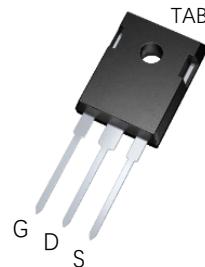


**900V 18A 0.65Ω N-ch Power MOSFET****Description**

TO-247

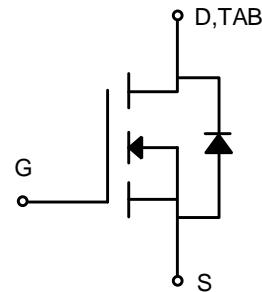
WMOS™ D1 is Wayon's 1<sup>st</sup> generation VDMOS family that is dramatic reduction in on-resistance and ultra-low gate charge for applications requiring high power density and high efficiency. And it is very robust and RoHS compliant.

**Features**

- Typ. $R_{DS(on)}=0.65\Omega$ @ $V_{GS}=10V$
- 100% avalanche tested
- Pb-free, Halogen free

**Applications**

- SMPS
- Charger
- DC-DC

**Absolute Maximum Ratings (T<sub>c</sub>=25°C)**

Parameter	Symbol	WMJ18N90D1	Unit
Drain-source voltage	$V_{DSS}$	900	V
Gate-source voltage	$V_{GS}$	$\pm 30$	V
Continuous drain current	$I_D$	18	A
Continuous drain current@T <sub>c</sub> =100°C		12	A
Pulsed drain current <sup>1</sup>	$I_{DM}$	72	A
Avalanche energy, single pulse <sup>2</sup>	$E_{AS}$	850	mJ
Power dissipation	$P_D$	595	W
Derate above 25°C		4.7	W/°C
Operating junction temperature	$T_j$	-55~150	°C
Storage temperature	$T_{stg}$	-55~150	°C
Continuous diode forward current	$I_S$	18	A
Diode pulse current	$I_{Spulse}$	72	A

**Thermal Characteristic**

Thermal resistance,junction-to-case	$R_{\theta JC}$	0.21	°C/W
Thermal resistance,junction-to-ambient	$R_{\theta JA}$	60	°C/W

**Electrical Characteristics of MOSFET**

				Min.	Typ.	Max.	
Drain-source breakdown voltage	$BV_{DSS}$	$I_D=250\mu A, V_{GS}=0V$	$T_C=25^\circ C$	900	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$I_D=250\mu A, V_{DS}=V_{GS}$	$T_J=25^\circ C$	2.5	-	4.5	V
Drain-source leakage current	$I_{DSS}$	$V_{DS}=900V, V_{GS}=0V$	$T_J=25^\circ C$	-	-	1	$\mu A$
		$V_{DS}=720V, V_{GS}=0V$	$T_J=125^\circ C$	-	-	400	$\mu A$
Gate-source leakage current,forward	$I_{GSSF}$	$V_{DS}=0V, V_{GS}=30V$	$T_J=25^\circ C$	-	-	100	nA
Gate-source leakage current,reverse	$I_{GSSR}$	$V_{DS}=0V, V_{GS}=-30V$	$T_J=25^\circ C$	-	-	-100	nA
Drain-source on-state resistance <sup>3</sup>	$R_{DS(ON)}$	$V_{GS}=10V, I_D=9A$	$T_J=25^\circ C$	-	0.65	0.78	$\Omega$
Transconductance <sup>3</sup>	$G_{fs}$	$V_{DS}=20V$	$T_J=25^\circ C$	-	9	-	S

**Dynamic Characteristics of MOSFET ( $T_C=25^\circ C$ )**

			Min.	Typ.	Max.
Input capacitance	$C_{iss}$	$f=1MHz, V_{DS}=25V, V_{GS}=0V$	-	3790	-
Output capacitance	$C_{oss}$		-	255	-
Reverse transfer capacitance	$C_{rss}$		-	110	-
Gate to source charge	$Q_{gs}$	$V_{DD}=450V, I_D=18A, V_{GS}= 0 \text{ to } 10V$	-	24	-
Gate to drain charge	$Q_{gd}$		-	24	-
Total gate charge	$Q_g$		-	77	-

**Switching Characteristics of MOSFET ( $T_C=25^\circ C$ )**

			Min.	Typ.	Max.
Turn-on delay time	$t_{d\ on}$	$V_{DS}=450V, I_D=18A, R_G=10\Omega, V_{GS}=0 \text{ to } 10V$	-	40	-
Rise time	$t_r$		-	70	-
Turn-off delay time	$t_{d\ off}$		-	55	-
Fall time	$t_f$		-	55	-

**Characteristics of Body Diode ( $T_C=25^\circ C$ )**

			Min.	Typ.	Max.
Forward voltage	$V_{SD}$	$I_{SD}=18A, V_{GS}=0V$	-	-	1.4
Reverse recovery time	$t_{rr}$	$I_s=18A, V_{GS}=0V$ $dI/dt=100A/\mu s$	-	820	-
Reverse recovery current	$I_{rr}$		-	19.5	-
Recovery charge	$Q_{rr}$		-	8	-

Notes:

1. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)} = 150^\circ C$ .
2. The EAS data shows Max. rating . The test condition is  $V_{DD} = 50V, V_{GS} = 10V, L = 20mH, I_{AS} = 9.7A, T_C = 25^\circ C$ .
3. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .

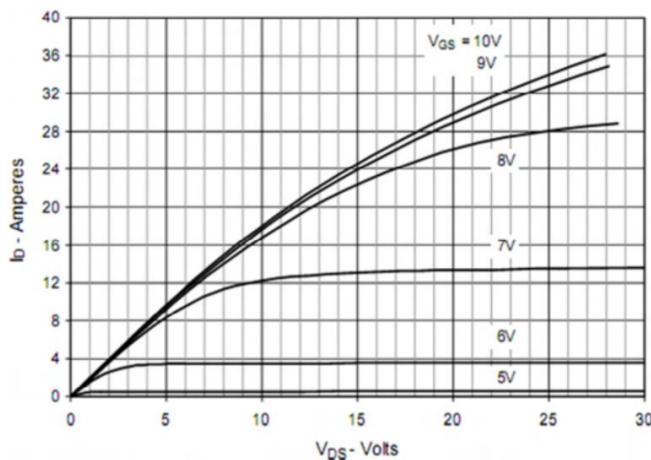


Figure 1. On-Region Characteristics

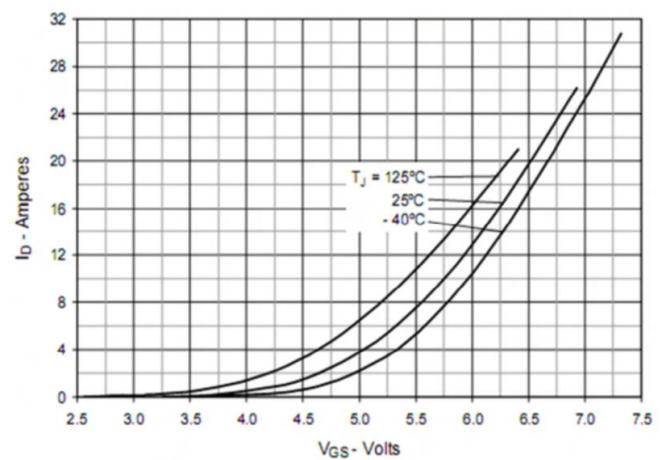


Figure 2. Transfer Characteristics

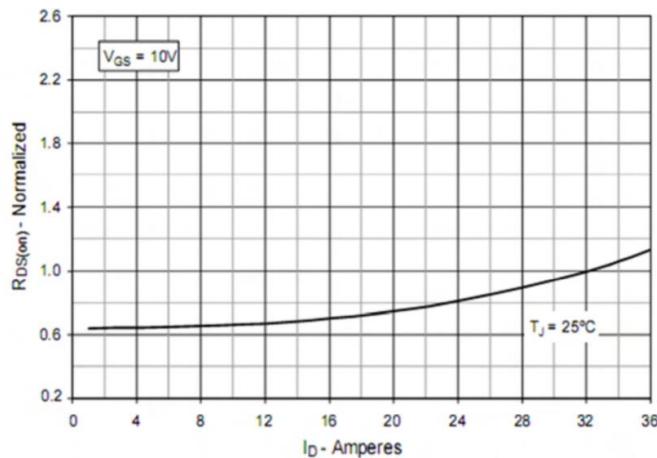


Figure 3. Normalized Static Drain-Source On Resistance

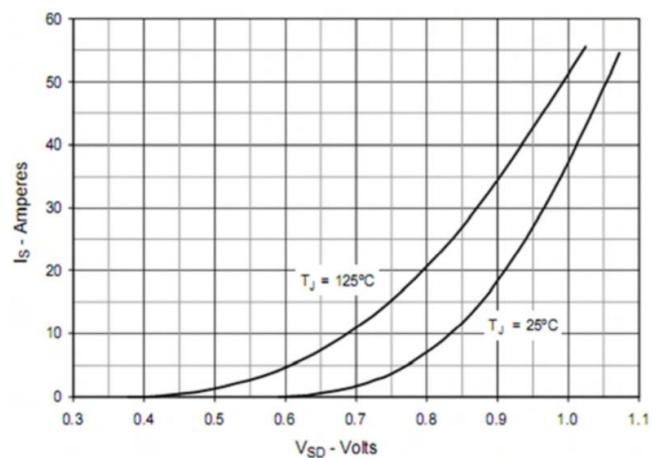


Figure 4. Typical Body Diode Transfer Characteristics

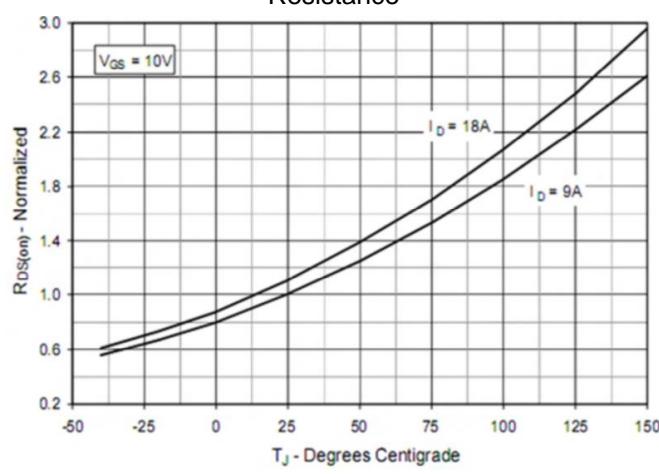
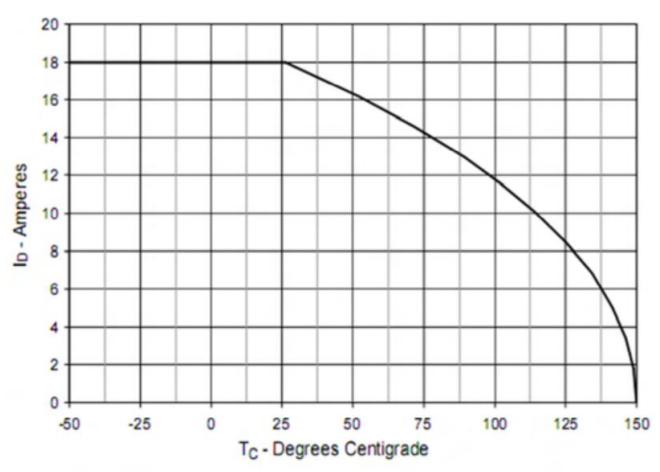
Figure 5. Normalized  $R_{DS(on)}$  vs. Temperature

Figure 6. Continuous Drain Current Derating vs. Case Temperature

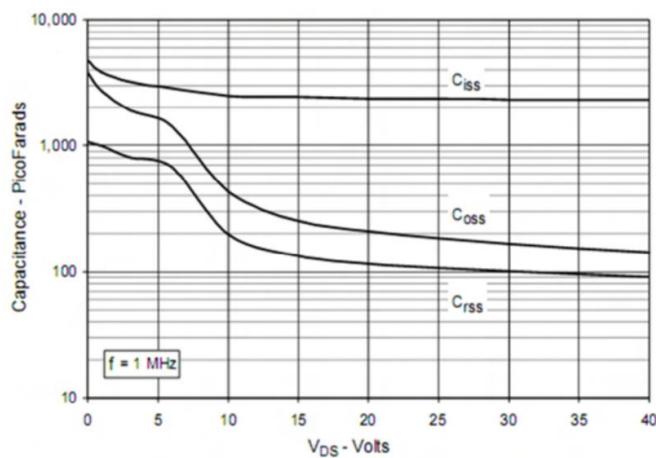


Figure 7. Capacitance Characteristics

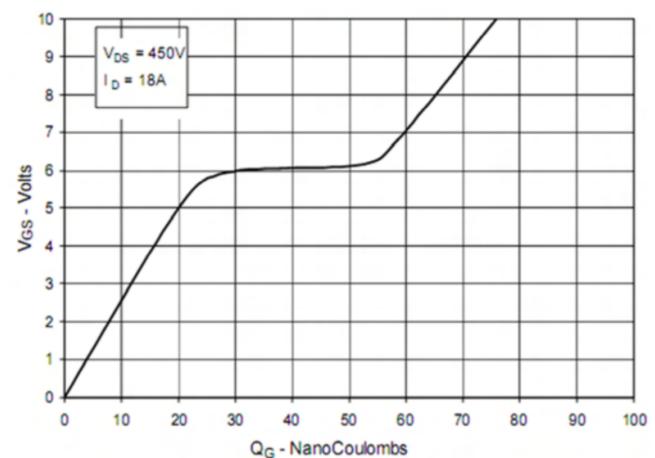
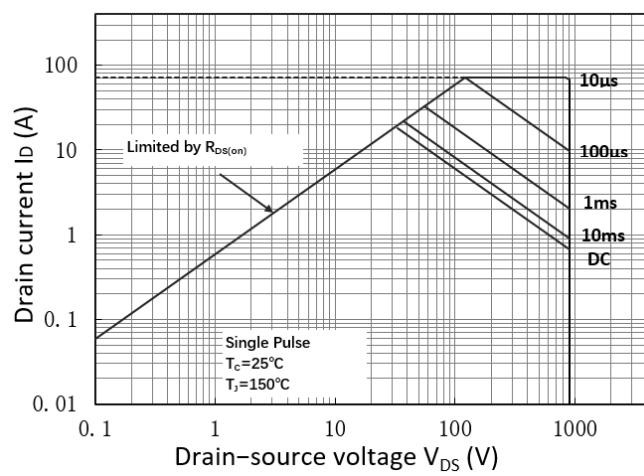
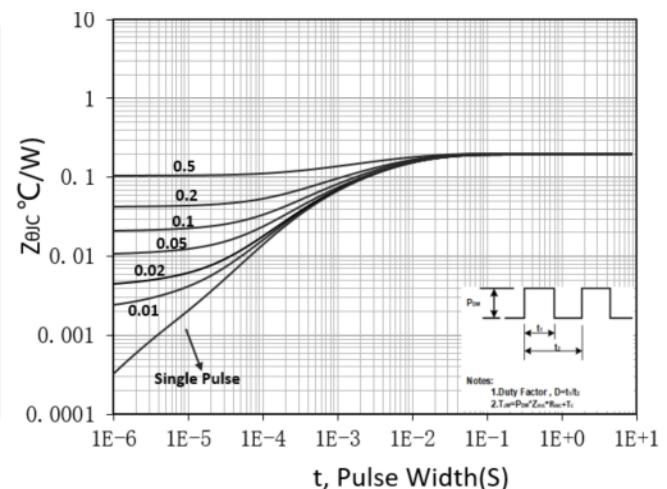
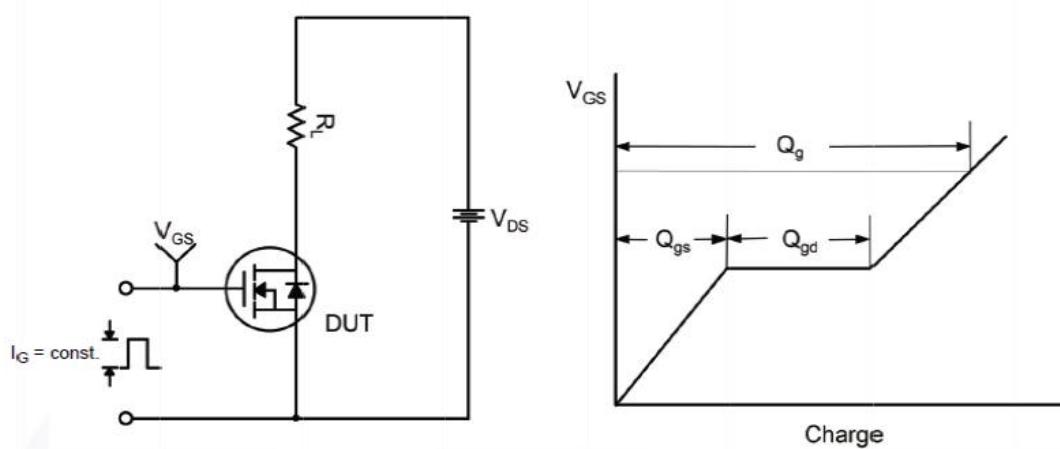


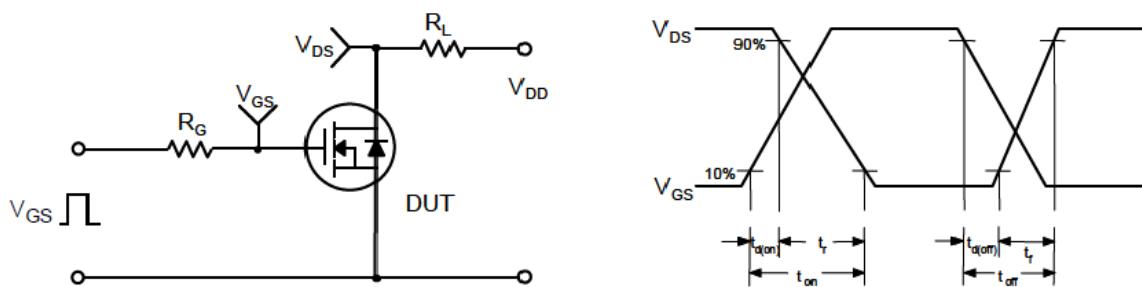
Figure 8. Gate Charge Characteristics

Figure 9. Maximum Safe Operating Area  
(TO-247)Figure 10. Transient Thermal Response Curve  
(TO-247)

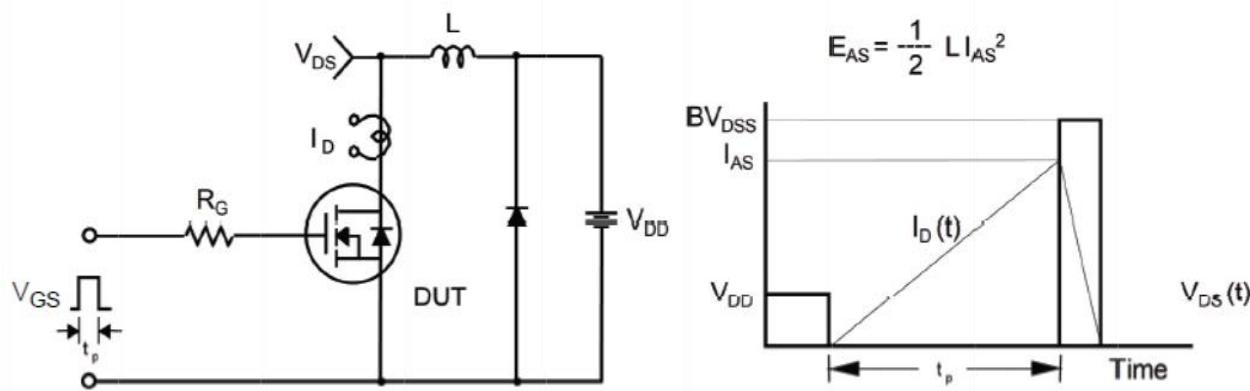
## Gate Charge Test Circuit &amp; Waveform

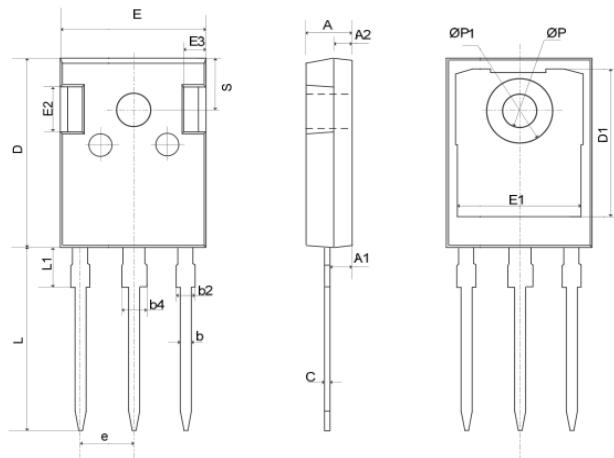


## Switching Test Circuit &amp; Waveforms



## Unclamped Inductive Switching Test Circuit &amp; Waveforms



**Mechanical Dimensions for TO-247****COMMON DIMENSIONS**

SYMBOL	MM	
	MIN	MAX
A	4.80	5.20
A1	2.21	2.61
A2	1.85	2.15
b	1.11	1.36
b2	1.91	2.21
b4	2.91	3.21
c	0.51	0.75
D	20.70	21.30
D1	16.25	16.85
E	15.50	16.10
E1	13.00	13.60
E2	4.80	5.20
E3	2.30	2.70
e	5.44BSC	
L	19.62	20.22
L1	—	4.30
ØP	3.40	3.80
ØP1	—	7.30
S	6.15BSC	

**Ordering Information**

Part	Package	Marking	Packing method
WMJ18N90D1	TO-247	WMJ18N90D1	Tube

## Contact Information

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